

Search Notes

Application/Control No.

10/673,625

Examiner

Steven J. Ganey

Applicant(s)/Patent under
Reexamination

NEIER ET AL.

Art Unit

3752

SEARCHED

Class	Subclass	Date	Examiner
239	661,664, 667,669, 672,673, 679		
	681,682	2/3/06	SSR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text and inventorship searched.	2/3/06	SSR